

<b>Notice of References Cited</b>	Application/Control No. 10/848,866	Applicant(s)/Patent Under Reexamination HART ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,064,376 A	05-2000	Berezowski et al.	725/42
*	B	US-2001/0030661 A1	10-2001	Reichardt, M. Scott	345/721
*	C	US-6,499,138 B1	12-2002	Swix et al.	725/38
*	D	US-6,526,577 B1	02-2003	Knudson et al.	725/40
*	E	US-6,571,390 B1	05-2003	Dunn et al.	725/52
*	F	US-6,721,953 B1	04-2004	Bates et al.	725/39
*	G	US-6,757,707 B1	06-2004	Houghton et al.	709/203
*	H	US-6,898,762 B2	05-2005	Ellis et al.	715/716
*	I	US-6,934,963 B1	08-2005	Reynolds et al.	725/39
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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